NOTICE: This standard has either been superseded and replaced by a new version or withdrawn. Contact ASTM International (www.astm.org) for the latest information.



Designation: F 638 – 88 (Reapproved 1995)^{€1}

AMERICAN SOCIETY FOR TESTING AND MATERIALS 100 Barr Harbor Dr., West Conshohocken, PA 19428 Reprinted from the Annual Book of ASTM Standards. Copyright ASTM

Standard Specification for Fine Aluminum—1 % Magnesium Wire for Semiconductor Lead-Bonding¹

This standard is issued under the fixed designation F 638; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

 ϵ^1 Note—Keywords were added editorially in June 1995.

1. Scope

1.1 This specification covers aluminum-1% magnesium alloy wire for internal connections in semiconductor devices and is limited to wires of diameter up to and including 0.002 in. (0.051 mm). For diameters larger than 0.0020 in. (0.051 mm), the specifications are to be agreed upon between the purchaser and the supplier.

1.2 The values stated in inch-pound units are to be regarded as the standard. The values stated in parentheses are for information only.

2. Referenced Documents

- 2.1 ASTM Standards:
- F 16 Test Methods for Measuring Diameter or Thickness of Wire and Ribbon for Electronic Devices and Lamps²
- F 72 Specification for Gold Wire for Semiconductor Lead Bonding²
- F 205 Test Method for Measuring Diameter of Fine Wire by Weighing ²
- F 219 Test Methods of Testing Fine Round and Flat Wire for Electron Devices and Lamps
- F 584 Practice for Visual Inspection of Semiconductor Lead Bonding Wire²
- 2.2 Military Standard:
- MIL-STD-105 Sampling Procedures and Tables for Inspection by Attributes ³

3. Ordering Information

3.1 Orders for material under this specification shall include the following information:

- 3.1.1 Quantity,
- 3.1.2 Composition (see Section 7),
- 3.1.3 Size (diameter) (see Section 5),
- 3.1.4 Breaking load and elongation (see Section 4),

² Annual Book of ASTM Standards, Vol 10.04.

3.1.5 Spooling, packaging, and marking (see Section 11), 3.1.6 Buyer part number, and

3.1.7 Special requirements such as for certificate of compliance (see Section 10).

4. Physical Requirements

4.1 Elongation and breaking load ranges for the wire shall be specified by the purchaser. The maximum ranges of the mechanical properties are listed in Table 1.

4.2 Mechanical property requirements in ranges smaller than those listed in Table 1 may be specified upon agreement between the purchaser and the supplier.

NOTE 1—The nature of aluminum-1 % magnesium alloy is such that the mechanical properties of both as-drawn and annealed wires overlap considerably. It is also possible to vary the properties of the hard wire by changing manufacturing parameters and procedures. For these reasons, no distinction is made in this specification between the two types.

5. Dimensions, Weights, and Permissible Variations

5.1 Wire size shall be expressed as wire diameter in decimal fractions of an inch (or millimetres) or as weight per unit length.

5.2 Tolerances for various size ranges are specified in Table 2.

5.3 When wire size is expressed in terms of weight, the following values shall be used:

5.3.1 Density of Aluminum-1 % Magnesium-2.7 g/cm³

5.3.2 Weight of a 200-mm Length of Wire 0.0254 mm in Diameter—0.274 mg.

6. Surface Finish

6.1 The wire surface shall be clean and free of finger oils, lubricant residues, stains, and particulate matter.

6.2 Mechanical damage to the wire surface such as nicks, scratches, and kinks shall be held to a minimum.

6.3 The nature and the extent of defects permitted to be present on the surface of the wire shall be agreed between the supplier and the purchaser.

7. Chemical Requirements

7.1 The alloy composition shall be 1.00 ± 0.15 % magnesium and between 98.84 and 99.15 % aluminum. All other elements are considered impurities.

¹ This specification is under the jurisdiction of ASTM Committee F-1 on Electronics and is the direct responsibility of Subcommittee F 01.07 on Interconnection Bonding Carrier Bonding.

Current edition approved May 27, 1988. Published July 1988. Originally published as F 638 - 82. Last previous edition F 638 - 82.

³ Available from Standardization Documents Order Desk, Bldg. 4 Section D, 700 Robbins Ave., Philadelphia, PA 19111-5094, Attn: NPODS.